



# SURFACE MOUNT GLASS PASSIVATED SILICON RECTIFIERS



S1A ~ S1M

DO-214AC (SMA) Plastic Package RoHS compliant

DO-214AC (SMA)

### Features:

- 1. Low profile package.
- 2. Glass passivated junction.

Applications: General Purpose Rectifiers

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PARAMETER	SYMBOL	S1A	S1B	S1D	S1G	S1J	S1K	S1M	UNIT
Maximum Recurrent Peak Reverse Voltage	V <sub>RRM</sub>	50	100	200	400	600	800	1000	V
Maximum RMS Voltage	V <sub>RMS</sub>	35	70	140	280	420	560	700	V
Maximum DC Blocking Voltage	V <sub>DC</sub>	50	100	200	400	600	800	1000	V
Maximum Average Forward Rectified @ T <sub>L</sub> =100°C	I <sub>F(AV)</sub>	) 1.0			А				
Peak Forward Surge Current 8.3ms single half sine wave superimposed on rated load(JEDEC method)	I <sub>FSM</sub>	30			А				
Maximum Forward Voltage @ 1A	V <sub>F</sub>	V <sub>F</sub> 1.1			V				
Maximum Reverse Current T <sub>a</sub> =25°C	1	5.0						mA	
Rated DC Blocking Voltage T <sub>a</sub> = 125°C	I <sub>R</sub> 100			- mA					
Typical Junction Capacitance <sup>(Note 1)</sup>	C <sub>J</sub> 12		pF						
Typical Thermal Resistance <sup>(Note 2)</sup>	R <sub>th (j-l)</sub> 30		°C/W						
Maximum Reverse Recovery Time <sup>(Note 3)</sup>	t <sub>rr</sub> 2.5		μs						
Operating Junction Temperature Range	T <sub>J</sub> -55 to +150		°C						
Storage Temperature Range	T <sub>stg</sub> -55 to +150		°C						

### **ABSOLUTE MAXIMUM RATINGS** (Ta = 25 °C Unless otherwise specified)

#### Note:

1. Measured at 1MHz and applied reverse voltage of 4.0 VDC.

2. Thermal resistance from junction to lead mounted on PCB with 0.3 x 0.3"(8.0 x 8.0mm) copper pad areas.

3. Reverse recovery test conditions :  $I_F$  = 0.5A,  $I_R$  = 1A,  $I_{rr}$  =0.25A.



# **TYPICAL CHARACTERISTICS CURVES**

Figure 1. Forward Current Derating Curve

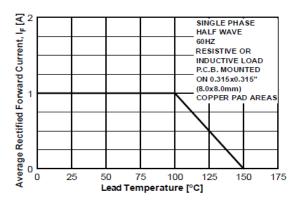
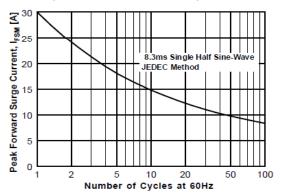
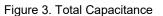


Figure 2. Non-Repetitive Surge Current





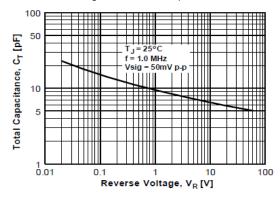


Figure 4. Forward Voltage Characteristics

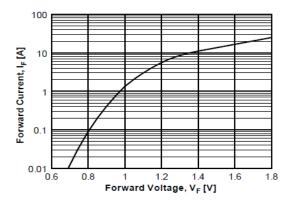


Figure 5. Reverse Current vs Reverse Voltage

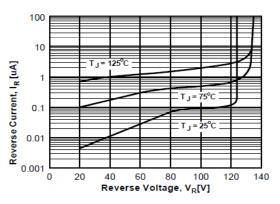
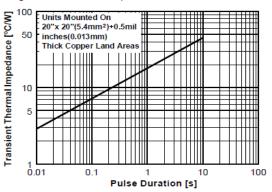


Figure 6. Thermal Impedance Characteristics

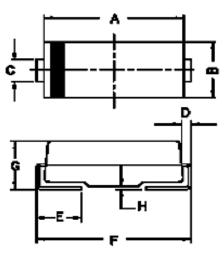


S1A\_S1M Rev02\_08072021E



# Package Details

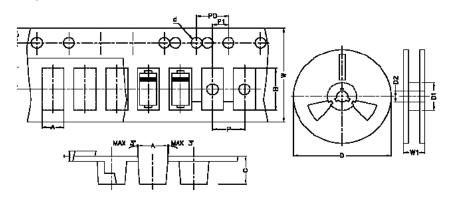
DO-214AC (SMA) Package Outline and Dimension



DIM	MIN	MAX
А	4.06	4.57
В	2.18	2.78
С	1.28	1.70
D	0.152	0.305
E	0.89	1.60
F	4.70	5.31
G	1.70	2.31
Н	0.102	0.203

All Dimensions are in mm

# **Reel Taping Specifications**



Item	Symbol	Specification(mm)	Specification (Inch)
Carrier Width	A	3.2 MAX	0.126 MAX
Carrier Length	В	7.8 MAX	0.307 MAX
Carrier Depth	С	4.5 MAX	0.177 MAX
Sprocket Hole	d	1.5 ±1.00	0.058 ±0.004
Reel Outside Diameter	D	178.0 ±2.00	7.00 ±0.078
Reel Inner Diameter	D1	50.0 MIN	1.989 MIN
Feed Hole Diameter	D2	13.0 ±0.50	0.512 ±0.020
Sprocket Hole Position	E	1.75 ±0.10	0.089 ±0.004
Punch Hole Position	F	5.5 ±0.10	0.217 ±0.004
Punch Hole Pitch	Р	4.0 ±0.10	0.157 ±0.004
Procket Hole Pitch	P0	4.0 ±0.10	0.157 ±0.004
Embossment Center	P1	2.0 ±0.05	0.079 ±0.002
Overall Tape Thickness	Т	1.1 MAX	0.043 MAX
Tape Width	W	12.0 ±0.30	0.472 ±0.12
Reel Width	W1	10.4 MAX	0.724 MAX





## <u>Recommended Product Storage Environment for Discrete</u> <u>Semiconductor Devices</u>

This storage environment assumes that the Diodes and transistors are packed properly inside the original packing supplied by CDIL.

- · Temperature 5 °C to 30 °C
- · Humidity between 40 to 70 %RH
- · Air should be clean.
- · Avoid harmful gas or dust.
- · Avoid outdoor exposure or storage in areas subject to rain or water spraying .
- · Avoid storage in areas subject to corrosive gas or dust. Product shall not be stored in areas exposed to direct sunlight.
- · Avoid rapid change of temperature.
- · Avoid condensation.
- · Mechanical stress such as vibration and impact shall be avoided.
- · The product shall not be placed directly on the floor.
- The product shall be stored on a plane area. They should not be turned upside down. They should not be placed against the wall.

#### Shelf Life of CDIL Products

The shelf life of products is the period from product manufacture to shipment to customers. The product can be unconditionally shipped within this period. The period is defined as 2 years.

If products are stored longer than the shelf life of 2 years the products shall be subjected to quality check as per CDIL quality procedure.

The products are further warranted for another one year after the date of shipment subject to the above conditions in CDIL original packing.

#### Floor Life of CDIL Products and MSL Level

When the products are opened from the original packing, the floor life will start. For this, the following JEDEC table may be referred:

JEDEC MSL Level				
Level	Time	Condition		
1	Unlimited	≤30 °C / 85% RH		
2	1 Year	≤30 °C / 60% RH		
2a	4 Weeks	≤30 °C / 60% RH		
3	168 Hours	≤30 °C / 60% RH		
4	72 Hours	≤30 °C / 60% RH		
5	48 Hours	≤30 °C / 60% RH		
5a	24 Hours	≤30 °C / 60% RH		
6	Time on Label(TOL)	≤30 °C / 60% RH		





### **Customer Notes**

#### **Component Disposal Instructions**

- 1. CDIL Semiconductor Devices are RoHS compliant, customers are requested to please dispose as per prevailing Environmental Legislation of their Country.
- 2. In Europe, please dispose as per EU Directive 2002/96/EC on Waste Electrical and Electronic Equipment (WEEE).

### Disclaimer

The product information and the selection guides facilitate selection of the CDIL's Semiconductor Device(s) best suited for application in your product(s) as per your requirement. It is recommended that you completely review our Data Sheet(s) so as to confirm that the Device(s) meet functionality parameters for your application. The information furnished in the Data Sheet and on the CDIL Web Site/CD are believed to be accurate and reliable. CDIL however, does not assume responsibility for inaccuracies or incomplete information. Furthermore, CDIL does not assume liability whatsoever, arising out of the application or use of any CDIL product; neither does it convey any license under its patent rights nor rights of others. These products are not designed for use in life saving /support appliances or systems. CDIL customers selling these products (either as individual Semiconductor Devices or incorporated in their end products), in any life saving/support appliances or systems or applications do so at their own risk and CDIL will not be responsible for any damages resulting from such sale(s).

CDIL strives for continuous improvement and reserves the right to change the specifications of its products without prior notice.



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